

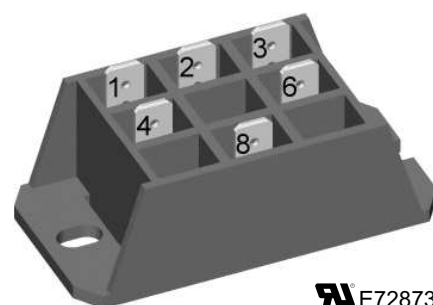
Half Controlled Single Phase Rectifier Bridge with Freewheeling Diode

$$I_{dAVM} = 40 \text{ A}$$

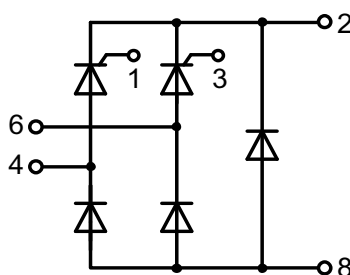
$$V_{RRM} = 800-1600 \text{ V}$$

Part numbers

V_{RSM} V_{DSM} V	V_{RRM} V_{DRM} V	Type
900	800	VHF 36-08io5
1300	1200	VHF 36-12io5
1700	1600	VHF 36-16io5



RL E72873



Features / Advantages:

- Planar passivated chips
- Space and weight savings
- Improved temperature & power cycling

Applications:

- Supply for DC power equipment
- DC motor control

Package: FO-F

- Isolation Voltage: 3600 V~
- DCB ceramic base plate
- 1/4" fast-on terminals
- Easy to mount with two screws
- RoHS compliant

Disclaimer Notice

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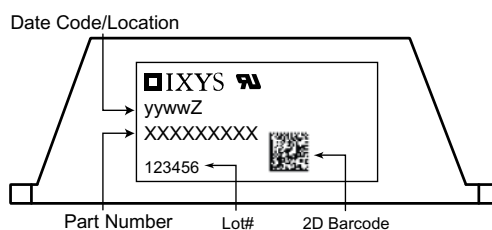
Diodes				Ratings			
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
I_{dAV}	average DC output current	module	$T_K = 85^\circ\text{C}$			36	A
I_{dAVM}	max. average DC output current	for resistive load				40	A
I_{FRMS}, I_{TRMS}	RMS forward current	per leg				28	A
I_{FSM}, I_{TSM}	max. surge forward current	$t = 10\text{ ms (50 Hz), sine}$	$T_{VJ} = 45^\circ\text{C}$			320	A
		$t = 8.3\text{ ms (60 Hz), sine; } V_R = 0\text{ V}$				350	A
		$t = 10\text{ ms (50 Hz), sine}$	$T_{VJ} = 125^\circ\text{C}$			280	A
		$t = 8.3\text{ ms (60 Hz), sine; } V_R = 0\text{ V}$				310	A
I^2t	I^2t value for fusing	$t = 10\text{ ms (50 Hz), sine}$	$T_{VJ} = 45^\circ\text{C}$			500	A^2s
		$t = 8.3\text{ ms (60 Hz), sine; } V_R = 0\text{ V}$				520	A^2s
		$t = 10\text{ ms (50 Hz), sine}$	$T_{VJ} = 125^\circ\text{C}$			390	A^2s
		$t = 8.3\text{ ms (60 Hz), sine; } V_R = 0\text{ V}$				400	A^2s
$(di/dt)_{cr}$	critical rate of rise of current	$f = 50\text{ Hz, } t_p = 200\text{ }\mu\text{s, } V_D = 2/3 V_{DRM}, T_{VJ} = 125^\circ\text{C}$ $I_G = 0.3\text{ A, } di_G/dt = 0.3\text{ A}/\mu\text{s}$ repetitive, $I_T = 50\text{ A}$ non repetitive, $I_T = 1/2 I_{dAV}$				150 500	$\text{A}/\mu\text{s}$ $\text{A}/\mu\text{s}$
$(dv/dt)_{cr}$	critical rate of rise of voltage	$V_D = 2/3 V_{DRM}, T_{VJ} = 125^\circ\text{C}$ $R_{GK} = \infty$; method 1 (linear voltage rise)				1000	$\text{V}/\mu\text{s}$
V_{RGM}	max. reverse gate voltage					10	V
P_{GM}	max. gate power dissipation	$I_T = I_{TAVM}$ $t_p = 30\text{ }\mu\text{s}$ $t_p = 500\text{ }\mu\text{s}$ $t_p = 10\text{ ms}$	$T_{VJ} = 125^\circ\text{C}$			10 5 1	W W W
P_{GAVM}	max. average gate power dissipation					0.5	W
Thyristors				Ratings			
Symbol	Definitions	Conditions		min.	typ.	max.	Unit
I_R, I_D	reverse, drain current	$V_R = V_{RRM}; V_D = V_{DRM}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$			0.3 5	mA mA
V_T, V_F	forward voltage	$I_T, I_F = 45\text{ A}$	$T_{VJ} = 25^\circ\text{C}$			1.45	V
V_{TO} r_T		For power-loss calculations only	$T_{VJ} = 125^\circ\text{C}$		0.85 13		V m Ω
V_{GT}	gate trigger voltage	$V_D = 6\text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$			1.0 1.2	V V
I_{GT}	gate trigger current	$V_D = 6\text{ V}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$			65 80 50	mA mA mA
V_{GD} I_{GD}	gate non-trigger voltage non-trigger gate current	$V_D = 2/3 V_{DRM}$	$T_{VJ} = 125^\circ\text{C}$			0.2 5	V mA
I_L	latching current	$I_G = 0.3\text{ A, } t_G = 30\text{ }\mu\text{s}$ $di_G/dt = 0.3\text{ A}/\mu\text{s}$	$T_{VJ} = 25^\circ\text{C}$ $T_{VJ} = -40^\circ\text{C}$ $T_{VJ} = 125^\circ\text{C}$			150 200 100	mA mA mA
I_H	holding current	$V_D = 6\text{ V, } R_{GK} = \infty$	$T_{VJ} = 25^\circ\text{C}$			100	ns
t_{gd}	gate controlled delay time	$V_D = 1/2 V_{DRM}$ $I_G = 0.3\text{ A, } di_G/dt = 0.3\text{ A}/\mu\text{s}$	$T_{VJ} = 25^\circ\text{C}$		2		μs
t_q Q_r	turn-off time reverse recovery charge	$I_T = 15\text{ A, } t_p = 300\text{ }\mu\text{s, } V_R = 100\text{ V; } T_{VJ} = 125^\circ\text{C}$ $di/dt = -10\text{ A}/\mu\text{s, } dv/dt = 20\text{ V}/\mu\text{s, } V_D = 2/3 V_{DRM}$			150 75		μs μC
R_{thJC}	thermal resistance junction to case	per thyristor (diode); DC current per module				1.15 0.29	K/W K/W
R_{thJH}	thermal resistance junction to heatsink	per thyristor (diode); DC current per module			1.55 0.39		K/W K/W

Data according to IEC 60747 and refer to a single thyristor/diode unless otherwise stated.

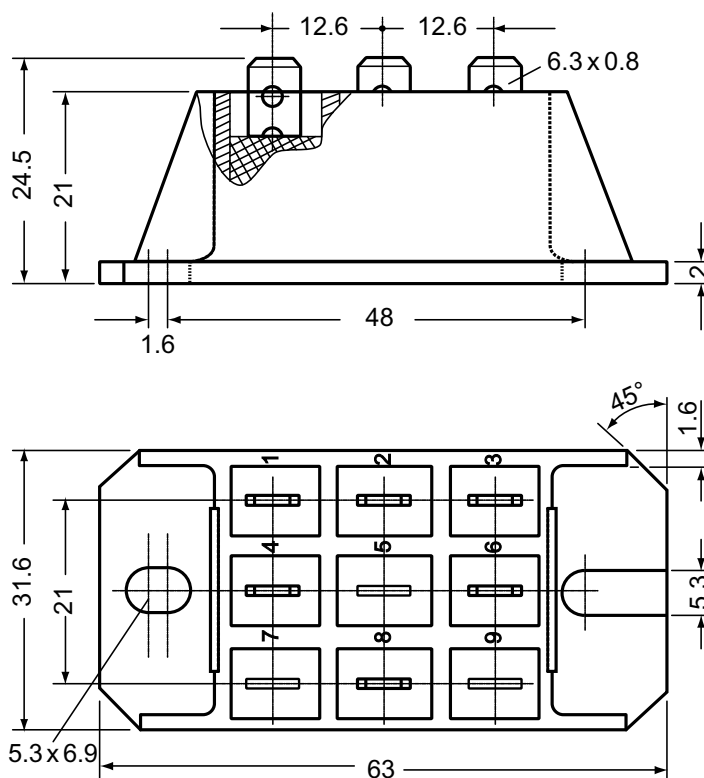
IXYS reserves the right to change limits, test conditions and dimensions.

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Package FO-F		Ratings			
Symbol	Definitions	Conditions	min.	typ.	max. Unit
I_{RMS}	RMS current	per terminal			100 A
T_{VJ}	virtual junction temperature		-40		125 °C
T_{op}	operation temperature		-40		100 °C
T_{stg}	storage temperature		-40		125 °C
Weight				45	g
M_D	mounting torque		2		2.5 Nm
$d_{Spp/App}$	creepage distance on surface / striking distance through air	terminal to terminal	18.0	6.0	mm
$d_{Spb/Appb}$		terminal to backside	26.0	20.0	mm
V_{ISOL}	isolation voltage	t = 1 second 50/60 Hz, RMS, $I_{ISOL} \leq 1$ mA t = 1 minute	3600		V
			3000		V



Dimensions in mm (1 mm = 0.0394")



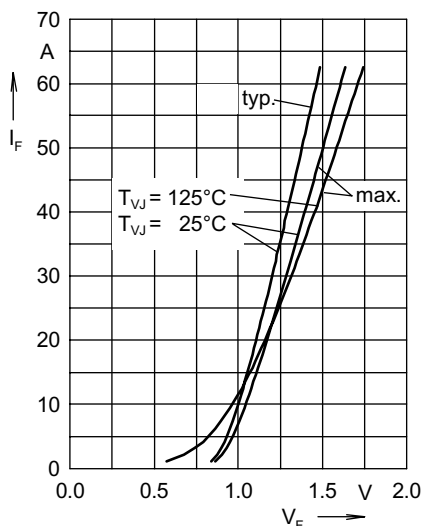


Fig. 3 Forward current versus voltage drop per diode

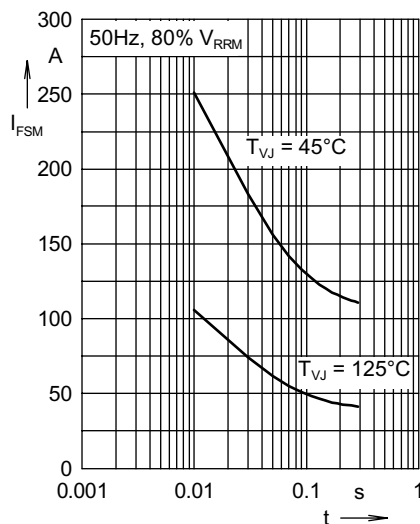


Fig. 4 Surge overload current

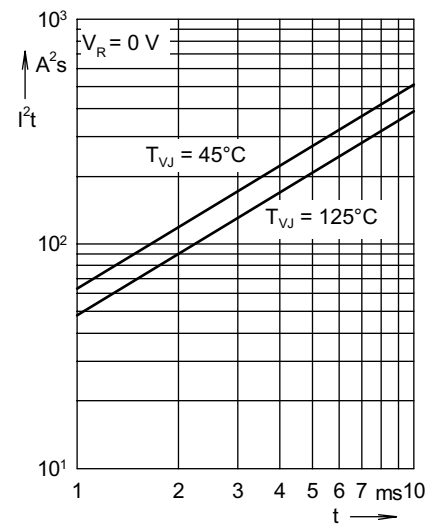


Fig. 5 I^2t versus time per diode

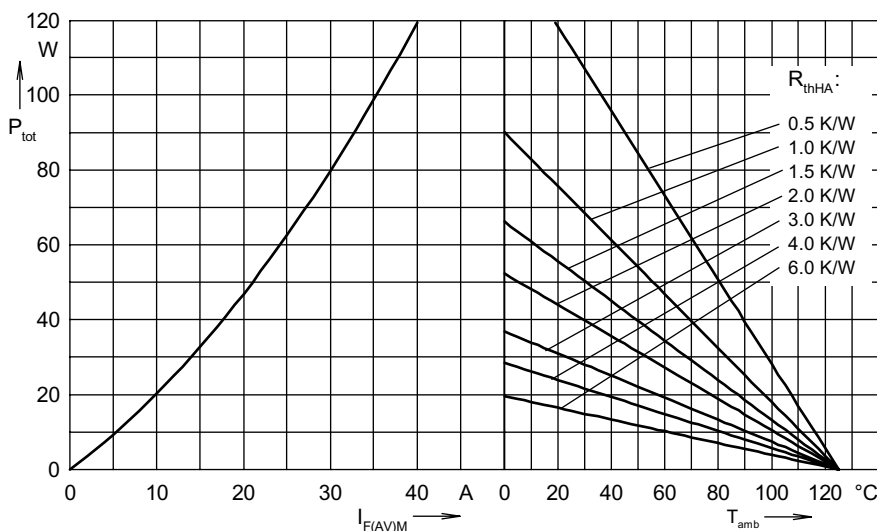


Fig. 6 Power dissipation versus direct output current and ambient temperature

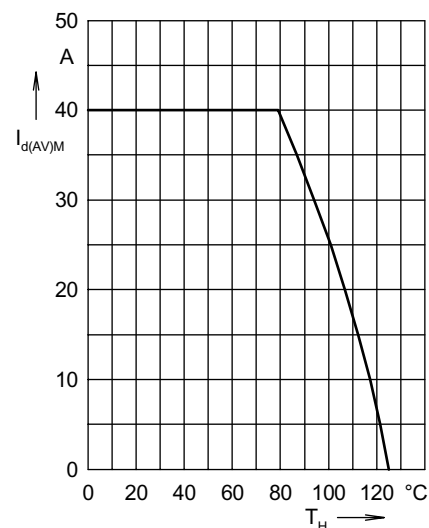


Fig. 7 Max. forward current versus heatsink temperature

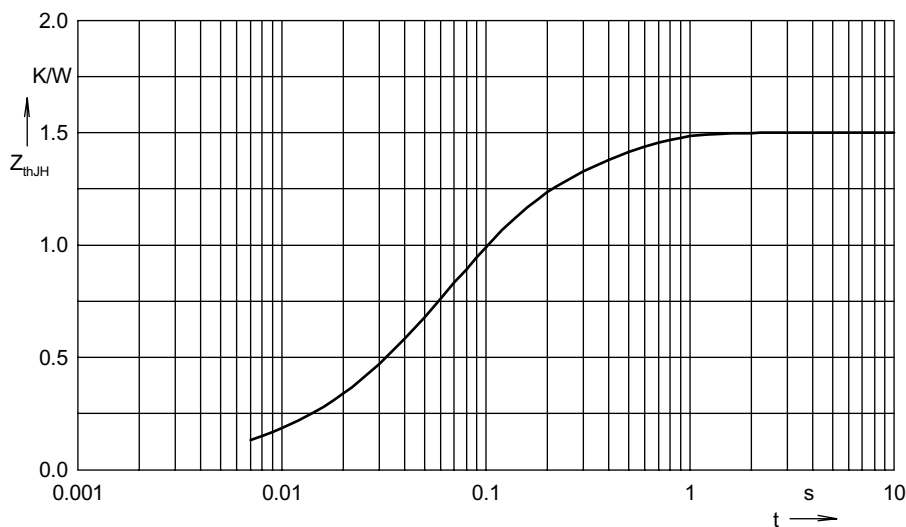


Fig. 8 Transient thermal impedance junction to heatsink

Constants for Z_{thJH} calculation:

i	R_{thi} (K/W)	t_i (s)
1	0.005	0.008
2	0.2	0.05
3	0.875	0.06
4	0.47	0.25